

MITSUBISHI LSTTLs
M74LS158P

QUADRUPLE 2-LINE TO 1-LINE DATA SELECTOR/MULTIPLEXER (INVERTED)

DESCRIPTION

The M74LS158P is a semiconductor integrated circuit containing four 2-line to 1-line data selector/multiplexer circuits.

FEATURES

- Converted outputs provided
- Strobe inputs provided independently for each circuits
- Selection inputs common to four circuits
- Low output impedance
- Wide operating temperature range ($T_a = -20 \sim +75^\circ\text{C}$)

APPLICATION

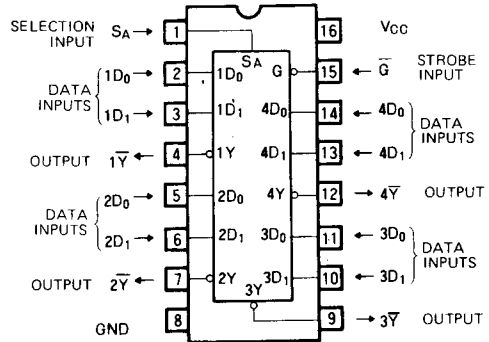
General purpose, for use in industrial and consumer equipment.

FUNCTIONAL DESCRIPTION

This IC has four data selector circuits which provide 2-line to 1-line selection for 4 pairs of signals using four multiplexer circuits which convert the 2-bit parallel data into serial data with time-sharing. When 2-line signals are applied to the data inputs D_0 and D_1 and 1 data is specified from among the data from selection input S_A , the input signal is inverted and can be output at \bar{Y} . By applying 2-bit parallel data to D_0 and D_1 , and connecting a binary counter output to S_A , the D_0 and D_1 data are inverted and appear in the order to D_0 and D_1 synchronized with the clock pulse. S_A and strobe input \bar{G} are common to all four circuits. When \bar{G} is set high, $1\bar{Y}$, $2\bar{Y}$, $3\bar{Y}$ and $4\bar{Y}$ are set high irrespective of the status of the inputs.

M74LS158P has the same functions and pin connections

PIN CONFIGURATION (TOP VIEW)



Outline 16P4

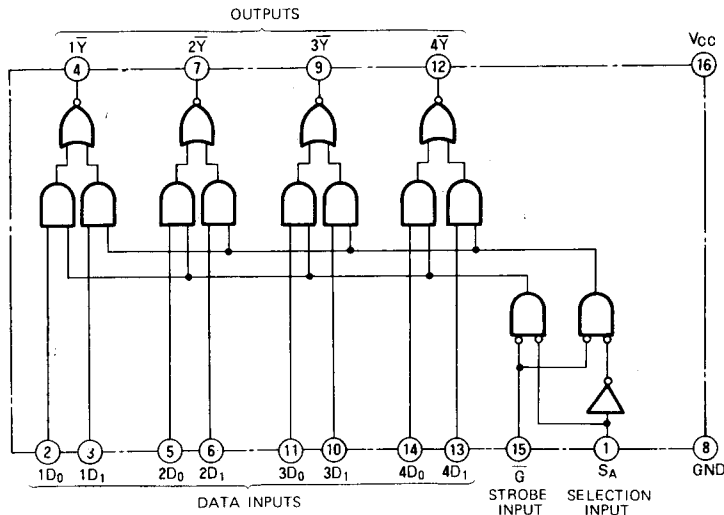
FUNCTION TABLE (Note 1)

\bar{G}	S_A	D_0	D_1	\bar{Y}
H	X	X	X	H
L	L	L	X	H
L	L	H	X	L
L	H	X	L	H
L	H	X	H	L

Note 1 X : Irrelevant

as M74LS258P but the latter is provided with 3-state outputs.

BLOCK DIAGRAM



QUADRUPLE 2-LINE TO 1-LINE DATA SELECTOR/MULTIPLEXER (INVERTED)

ABSOLUTE MAXIMUM RATINGS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V_{CC}	Supply voltage		$-0.5 \sim +7$	V
V_I	Input voltage		$-0.5 \sim +15$	V
V_O	Output voltage	High-level state	$-0.5 \sim +7$	V
T_{opr}	Operating free-air ambient temperature range		$-20 \sim +75$	$^\circ\text{C}$
T_{stg}	Storage temperature range		$-65 \sim +150$	$^\circ\text{C}$

RECOMMENDED OPERATING CONDITIONS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V_{CC}	Supply voltage	4.75	5	5.25	V
I_{OH}	High-level output current	$V_{OH} \geq 2.7\text{V}$	0	-400	μA
I_{OL}	Low-level output current	$V_{OL} \leq 0.4\text{V}$	0	4	mA
		$V_{OL} \leq 0.5\text{V}$	0	8	mA

ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ *	Max	
V_{IH}	High-level input voltage		2			V
V_{IL}	Low-level input voltage				0.8	V
V_{IC}	Input clamp voltage	$V_{CC} = 4.75\text{V}$, $I_{IC} = -18\text{mA}$			-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = 4.75\text{V}$, $V_I = 0.8\text{V}$ $V_I = 2\text{V}$, $I_{OH} = -400\mu\text{A}$	2.7	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = 4.75\text{V}$		0.25	0.4	V
		$V_I = 0.8\text{V}$, $V_I = 2\text{V}$		0.35	0.5	V
I_{IH}	High-level input current	D_0, D_1	$V_{CC} = 5.25\text{V}$		20	μA
		S_A, \bar{G}	$V_I = 2.7\text{V}$		40	μA
		D_0, D_1	$V_{CC} = 5.25\text{V}$		0.1	mA
		S_A, \bar{G}	$V_I = 10\text{V}$		0.2	mA
I_{IL}	Low-level input current	D_0, D_1	$V_{CC} = 5.25\text{V}$		-0.4	mA
		S_A, \bar{G}	$V_I = 0.4\text{V}$		-0.8	mA
I_{OS}	Short-circuit output current (Note 2)	$V_{CC} = 5.25\text{V}$, $V_O = 0\text{V}$	-20		-100	mA
I_{CCH}	High level supply current	$V_{CC} = 5.25\text{V}$ (Note 3)		4.8	8	mA
I_{CCL}	Low-level supply current	$V_{CC} = 5.25\text{V}$ (Note 4)		6.5	11	mA

* : All typical values are at $V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$.

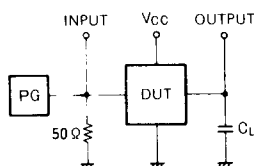
Note 2: All measurements should be done quickly, and not more than one output should be shorted at a time. Note 3: I_{CC} is measured with all inputs at 4.5V.

Note 4: The supply current should be measured with $1D_0 \sim 4D_0$ and the other inputs at 0V.

SWITCHING CHARACTERISTICS ($V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$, unless otherwise noted)

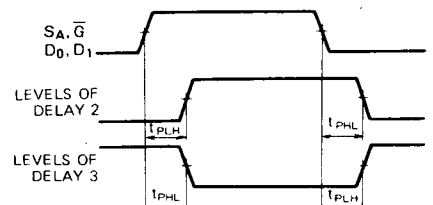
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from inputs D_0, D_1 to output \bar{Y}	$C_L = 15\text{pF}$ (Note 5)		5	12	ns
t_{PHL}				5	12	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input S_A to output \bar{Y}			9	20	ns
t_{PHL}				10	24	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input \bar{G} to output \bar{Y}			8	17	ns
t_{PHL}				8	18	ns

Note 5: Measurement circuit



- (1) The pulse generator (GP) has the following characteristics:
PRR = 1MHz, $t_r = 6\text{ns}$, $t_f = 6\text{ns}$, $t_w = 500\text{ns}$,
 $V_p = 3\text{Vp.p.}$, $Z_0 = 50\Omega$.
- (2) C_L includes probe and jig capacitance.

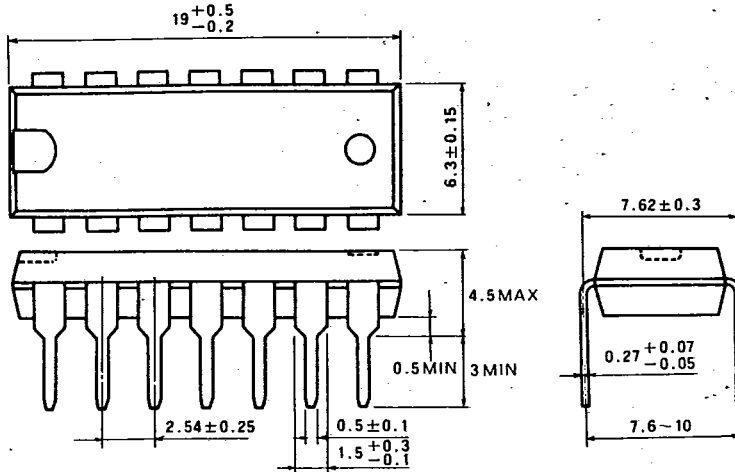
TIMING DIAGRAM (Reference level = 1.3V)



T-90-20

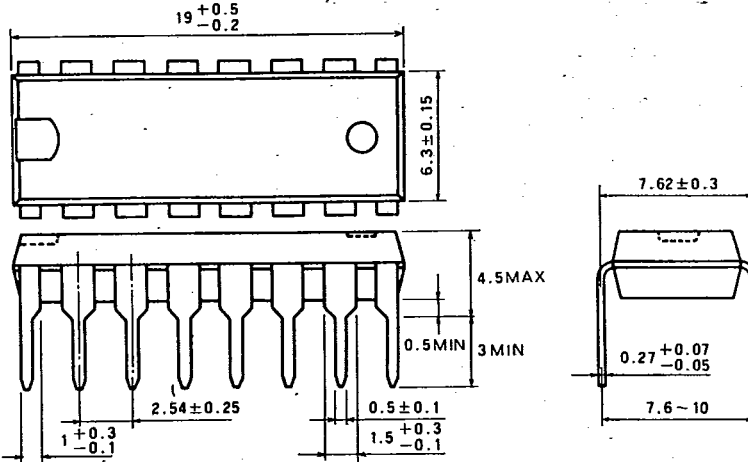
TYPE 14P4 14-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 16P4 16-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 20P4 20-PIN MOLDED PLASTIC DIL

Dimension in mm

